

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/751,705	HOSHINO, KIYO		
Examiner	Art Unit		
Dwayne I White	3745		

SEARCHED				
Class	Subclass	Date	Examiner	
416	5,62,207,2 09,208	5/24/65	Don	
	226;219R			
	240;132R			
	132A;70A			
	70R			
135	117,119	6/8/65	200%	
	128,24			
296	97.7,97.8			
297	184			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search	5/24/2005	DJW		
Plus Search	6/8/2005	DJW		
Consulted Chris Verdier	5/24/2005	DJW		
Consulted Ed Look	6/8/2005	DJW		